Application/Control No. Applicant(s)/Patent Under Reexamination 10/501,694 VAN DER VLEUTEN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2629 Seokyun Moon **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY * 438/30 US-2002/0142504 10-2002 Feldman et al. 03-1995 Amagami et al. 345/698 US-5,402,149 В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) υ ٧

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